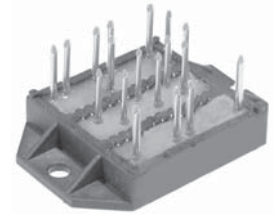
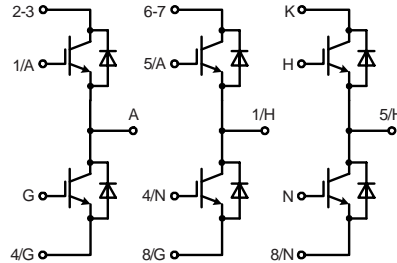


# IGBT Module

Sixpack in ECO-PAC 1

$I_{C25} = 19 \text{ A}$   
 $V_{CES} = 600 \text{ V}$   
 $V_{CE(sat) \text{ typ.}} = 1.9 \text{ V}$

Preliminary



Pin arrangement see outlines

IGBTs		
Symbol	Conditions	Maximum Ratings
$V_{CES}$	$T_{VJ} = 25^{\circ}\text{C to } 150^{\circ}\text{C}$	600 V
$V_{GES}$		$\pm 20$ V
$I_{C25}$	$T_C = 25^{\circ}\text{C}$	19 A
$I_{C80}$	$T_C = 80^{\circ}\text{C}$	14 A
$I_{CM}$ $V_{CEK}$	$V_{GE} = \pm 15 \text{ V}; R_G = 82 \Omega; T_{VJ} = 125^{\circ}\text{C}$ RBSOA, Clamped inductive load; $L = 100 \mu\text{H}$	20 A
$t_{SC}$ (SCSOA)		$V_{CE} = 720 \text{ V}; V_{GE} = \pm 15 \text{ V}; R_G = 82 \Omega; T_{VJ} = 125^{\circ}\text{C}$ non-repetitive
$P_{tot}$	$T_C = 25^{\circ}\text{C}$	73 W

### Features

- NPT IGBT's
  - positive temperature coefficient of saturation voltage
  - fast switching
- FRED diodes
  - fast reverse recovery
  - low forward voltage
- Industry Standard Package
  - solderable pins for PCB mounting
  - isolated DCB ceramic base plate

### Typical Applications

- AC drives
- power supplies with power factor correction

Symbol	Conditions	Characteristic Values ( $T_{VJ} = 25^{\circ}\text{C}$ , unless otherwise specified)			
		min.	typ.	max.	
$V_{CE(sat)}$	$I_C = 10 \text{ A}; V_{GE} = 15 \text{ V}; T_{VJ} = 25^{\circ}\text{C}$ $T_{VJ} = 125^{\circ}\text{C}$		1.9 2.2	V V	
$V_{GE(th)}$	$I_C = 0.35 \text{ mA}; V_{GE} = V_{CE}$	4.5		6.5 V	
$I_{CES}$	$V_{CE} = V_{CES}; V_{GE} = 0 \text{ V}; T_{VJ} = 25^{\circ}\text{C}$ $T_{VJ} = 125^{\circ}\text{C}$		2.7	0.6 mA mA	
$I_{GES}$	$V_{CE} = 0 \text{ V}; V_{GE} = \pm 20 \text{ V}$			100 nA	
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $E_{on}$ $E_{off}$	Inductive load, $T_{VJ} = 125^{\circ}\text{C}$ $V_{CE} = 300 \text{ V}; I_C = 10 \text{ A}$ $V_{GE} = \pm 15 \text{ V}; R_G = 82 \Omega$		35 35 230 30	ns ns ns ns	
				0.4 0.3	mJ mJ
$C_{ies}$		$V_{CE} = 25 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz}$		600	pF
$Q_{Gon}$		$V_{CE} = 300 \text{ V}; V_{GE} = 15 \text{ V}; I_C = 10 \text{ A}$		39	nC
$R_{thJC}$ $R_{thJH}$		(per IGBT) with heatsink compound ( $0.42 \text{ K/m.K}; 50 \mu\text{m}$ )		3.4	1.7 KW KW

IXYS reserves the right to change limits, test conditions and dimensions.

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IXYS Semiconductor GmbH  
Edisonstr. 15, D-68623 Lampertheim  
Phone: +49-6206-503-0, Fax: +49-6206-503627

www.ixys.com

IXYS Corporation  
3540 Bassett Street, Santa Clara CA 95054  
Phone: (408) 982-0700, Fax: 408-496-0670

**Diodes**

Symbol	Conditions	Maximum Ratings	
$I_{F25}$	$T_C = 25^\circ\text{C}$	21	A
$I_{F80}$	$T_C = 80^\circ\text{C}$	14	A

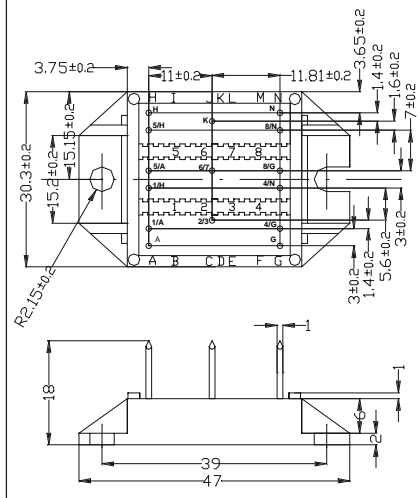
Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$V_F$	$I_F = 10\text{ A}; T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$	1.9	2.1	V
$I_{RM}$ $t_{rr}$	$I_F = 10\text{ A}; di_F/dt = -400\text{ A}/\mu\text{s}; T_{VJ} = 125^\circ\text{C}$ $V_R = 300\text{ V}; V_{GE} = 0\text{ V}$	11		A
		80		ns
$R_{thJC}$ $R_{thJH}$	with heatsink compound (0.42 K/m.K; 50 $\mu\text{m}$ )	7.0		3.5 K/W K/W

Data according to IEC 60747 and refer to a single diode unless otherwise stated.

**Component**

Symbol	Conditions	Maximum Ratings	
$T_{VJ}$		-40...+150	$^\circ\text{C}$
$T_{stg}$		-40...+125	$^\circ\text{C}$
$V_{ISOL}$	$I_{ISOL} \leq 1\text{ mA}; 50/60\text{ Hz}; t = 1\text{ s}$	3600	V~
$M_d$	mounting torque (M4)	1.5 - 2.0 14 - 18	Nm lb.in.
<b>a</b>	Max. allowable acceleration	50	$\text{m/s}^2$

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$d_s$	Creepage distance on surface (Pin to heatsink)	11.2		mm
$d_A$	Strike distance in air (Pin to heatsink)	11.2		mm
<b>Weight</b>		20		g

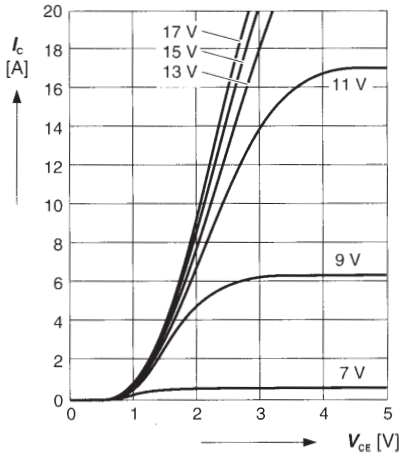
**Dimensions in mm (1 mm = 0.0394")**


## IGBT

### Typ. output characteristics

$$I_C = f(V_{CE})$$

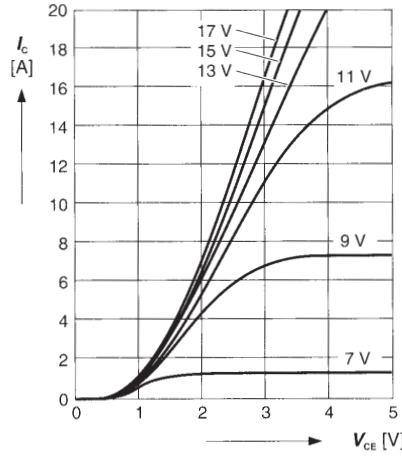
parameter:  $t_b = 250 \mu s$ ;  $T_j = 25^\circ C$



### Typ. output characteristics

$$I_C = f(V_{CE})$$

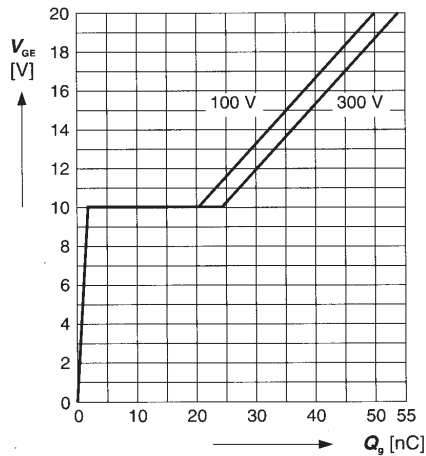
parameter:  $t_b = 250 \mu s$ ;  $T_j = 125^\circ C$



### Typ. gate charge

$$V_{GE} = f(Q_g)$$

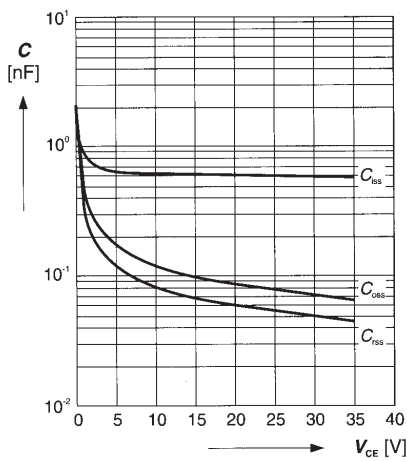
parameter:  $I_{C\ puls} = 10\ A$



### Typ. capacitances

$$C = f(V_{CE})$$

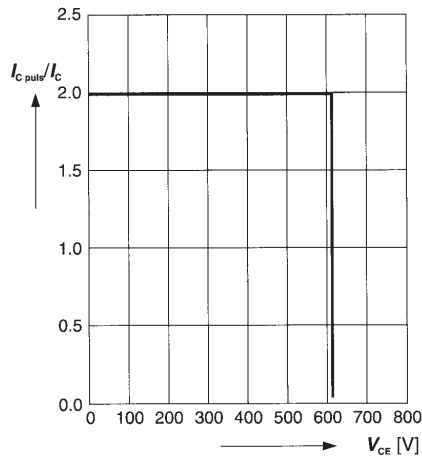
parameter:  $V_{GE} = 0\ V$ ;  $f = 1\ MHz$



### Reverse biased safe operating area

$$I_{C\ puls} = f(V_{CE}), T_j = 150^\circ C$$

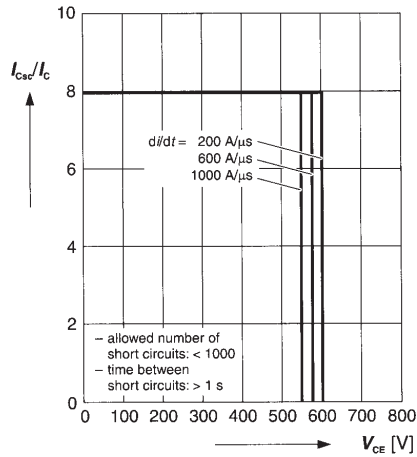
parameter:  $V_{GE} = 15\ V$



### Short circuit safe operating area

$$I_{Csc} = f(V_{CE}), T_j = 150^\circ C$$

parameter:  $V_{GE} = \pm 15\ V$ ;  $t_{sc} \le 10\ \mu s$ ;  $L < 60\ nH$

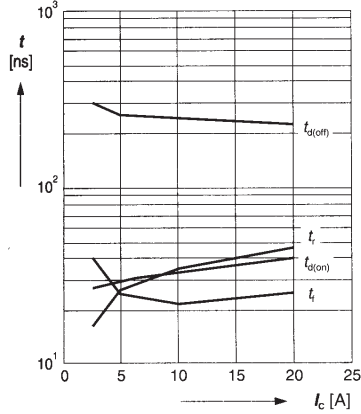


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## IGBT

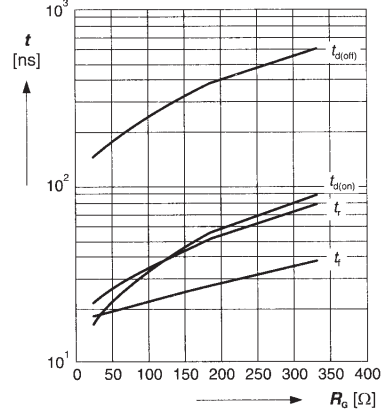
### Typ. switching time

$t = f(I_C)$ , inductive load,  $T_j = 125^\circ\text{C}$   
 parameter:  $V_{CE} = 300\text{ V}$ ;  $V_{GE} = \pm 15\text{ V}$ ;  $R_G = 100\ \Omega$



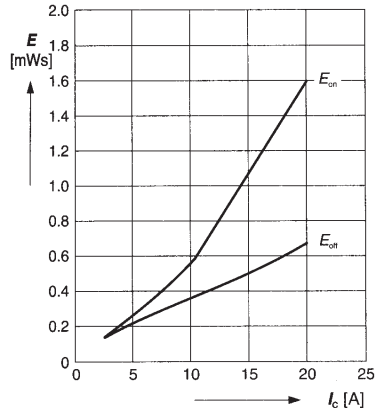
### Typ. switching time

$t = f(R_G)$ , inductive load,  $T_j = 125^\circ\text{C}$   
 parameter:  $V_{CE} = 300\text{ V}$ ;  $V_{GE} = \pm 15\text{ V}$ ;  $I_C = 10\text{ A}$



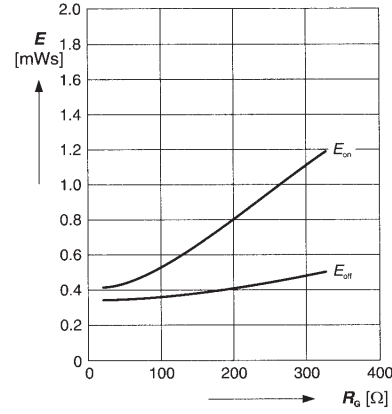
### Typ. switching losses

$E = f(I_C)$ , inductive load,  $T_j = 125^\circ\text{C}$   
 parameter:  $V_{CE} = 300\text{ V}$ ;  $V_{GE} = \pm 15\text{ V}$ ;  $R_G = 100\ \Omega$

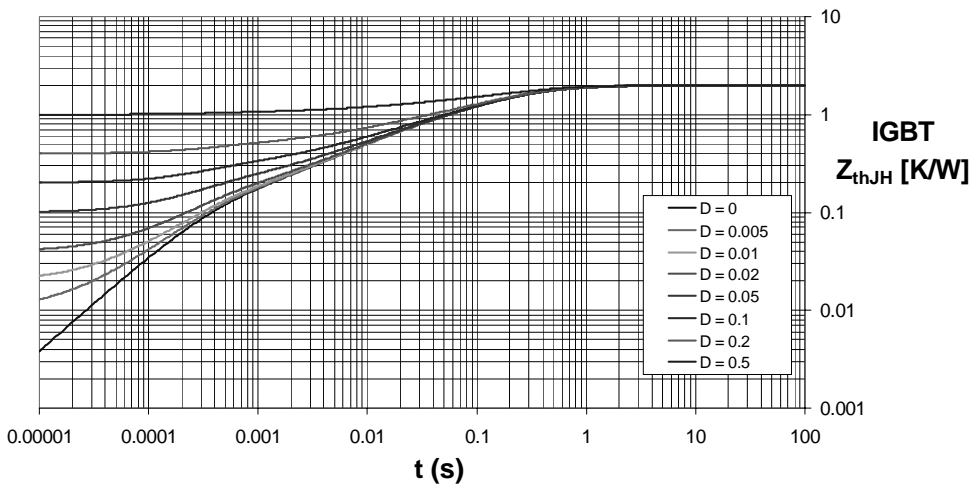


### Typ. switching losses

$E = f(R_G)$ , inductive load,  $T_j = 125^\circ\text{C}$   
 parameter:  $V_{CE} = 300\text{ V}$ ;  $V_{GE} = \pm 15\text{ V}$ ;  $I_C = 10\text{ A}$

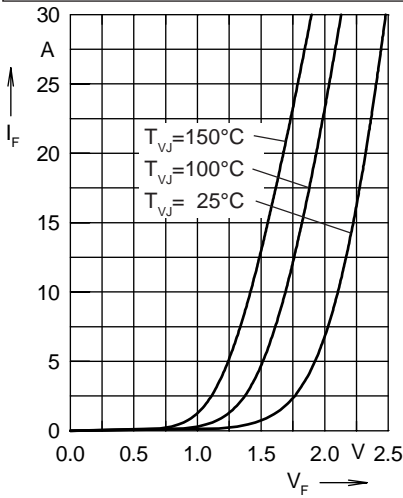


### Transient thermal resistance junction to heatsink

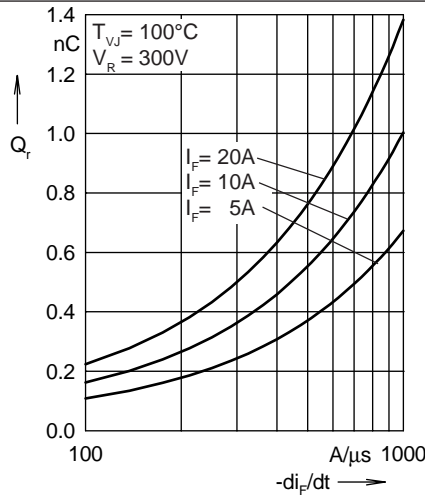


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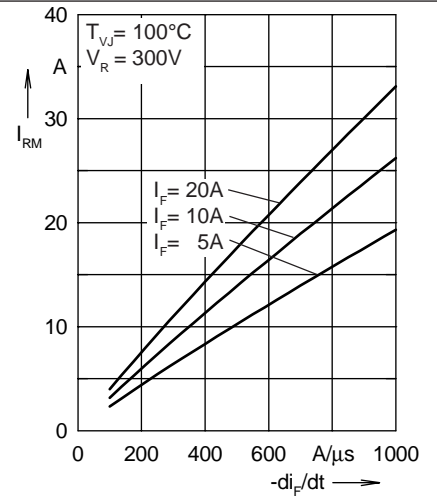
**Diode**



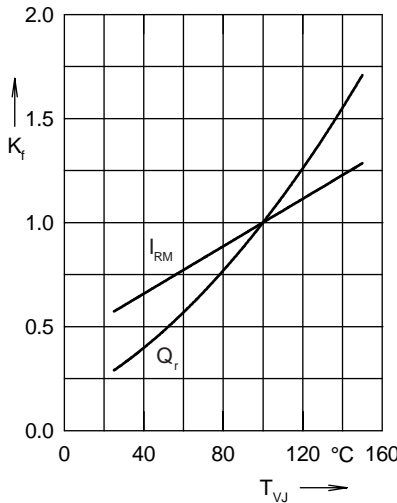
Forward current  $I_F$  versus  $V_F$



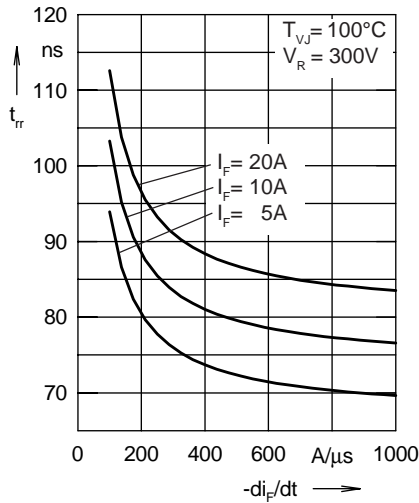
Reverse recovery charge  $Q_r$  versus  $-di_F/dt$



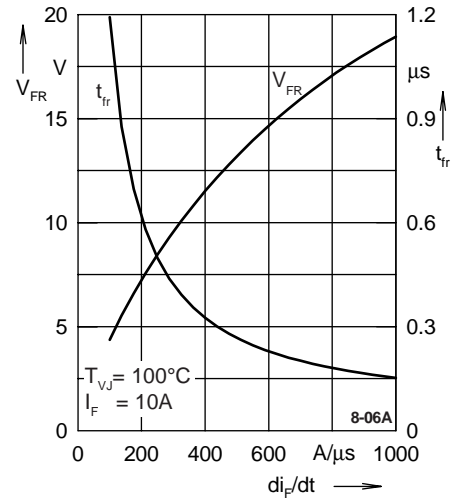
Peak reverse current  $I_{RM}$  versus  $-di_F/dt$



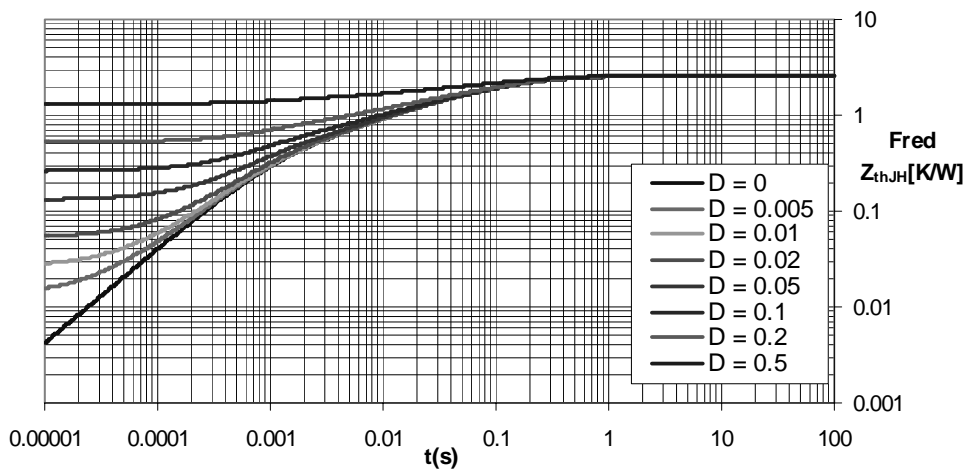
Dynamic parameters  $Q_r$ ,  $I_{RM}$  versus  $T_{VJ}$



Recovery time  $t_{rr}$  versus  $-di_F/dt$



Peak forward voltage  $V_{FR}$  and  $t_{rr}$  versus  $di_F/dt$



Transient thermal resistance junction to heatsink

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